RENESAS

DATASHEET

ISL83080E/82E/83E/84E/85E/86E/88E

±15kV ESD, 5V, Full Fail-Safe, 1/8 Unit Load, RS-485/RS-422 Transceivers

FN6085 Rev 10.00 February 15, 2016

The ISL8308xE are BiCMOS, ESD protected, 5V powered, single transceivers that meet both the RS-485 and RS-422 standards for balanced communication. Each driver output, and receiver input, is protected against \pm 15kV ESD strikes without latch-up, and unlike competitive products, this Intersil family is specified for 10% tolerance supplies (4.5V to 5.5V).

These devices have very low bus currents (+125 μ A/-75 μ A), so they present a true "1/8 unit load" to the RS-485 bus. This allows up to 256 transceivers on the network without violating the RS-485 specification's 32 unit load maximum, and without using repeaters. For example, in a remote utility meter reading system, individual meter readings are routed to a concentrator via an RS-485 network, so the high allowed node count minimizes the number of repeaters required. Data for all meters is then read out from the concentrator via a single access port, or a wireless link.

Receiver (Rx) inputs feature a "Full Fail-Safe" design, which ensures a logic high Rx output if Rx inputs are floating, shorted, or terminated but undriven.

The ISL83080E, ISL83082E, ISL83083E, ISL83084E, ISL83085E utilize slew rate limited drivers which reduce EMI, and minimize reflections from improperly terminated transmission lines, or unterminated stubs in multidrop and multipoint applications. Slew rate limited versions also include receiver input filtering to enhance noise immunity in the presence of slow input signals.

Hot Plug circuitry ensures that the Tx and Rx outputs remain in a high impedance state until the power supply has stabilized, and the Tx outputs are fully short circuit protected.

The ISL83080E, ISL83083E, ISL83084E, ISL83086E are configured for full duplex (separate Rx input and Tx output pins) applications. The half duplex versions multiplex the Rx inputs and Tx outputs to allow transceivers with output disable functions in 8 Ld packages.

Features

- Pb-Free Available (RoHS Compliant)
- Tiny MSOP Packages Save 50% Board Space
- Full Fail-Safe (Open, Short, Terminated and Floating) Receivers
- Hot Plug Circuitry (ISL83080E, ISL83082E, ISL83083E, ISL83085E)
 - Tx and Rx Outputs Remain Three-state During Power-up/Power-down
- True 1/8 Unit Load Allows up to 256 Devices on the Bus
- Specified for Single 5V, 10% Tolerance, Supplies
- High Data Rates..... up to 10Mbps
- -7V to +12V Common Mode Input Voltage Range
- · Half and Full Duplex Pinouts
- Three-State Rx and Tx Outputs (Except ISL83084E)
- Current Limiting and Thermal Shutdown for driver Overload Protection

Applications

- Automated Utility Meter Reading Systems
- High Node Count Systems
- Factory Automation
- Field Bus Networks
- Security Camera Networks
- Building Environmental Control Systems
- Industrial/Process Control Networks



ISL83080E/82E/83E/84E/85E/86E/88E

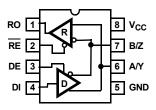
PART NUMBER	HALF/FULL DUPLEX	DATA RATE (Mbps)	SLEW- RATE LIMITED?	HOT PLUG	# DEVICES ON BUS	Rx/Tx ENABLE?	QUIESCEN T I _{CC} (μΑ)	LOW POWER SHUTDOWN?	PIN COUNT	
ISL83080E	Full	0.115	Yes	Yes	256	Yes	530	Yes	10, 14	
ISL83082E	Half	0.115	Yes	Yes	256	Yes	530	Yes	8	
ISL83083E	Full	0.5	Yes	Yes	256	Yes	530	Yes	10, 14	
ISL83084E (No longer available or supported)	Full	0.5	Yes	No	256	No	530	No	8	
ISL83085E	Half	0.5	Yes	Yes	256	Yes	530	Yes	8	
ISL83086E	Full	10	No	No	256	Yes	530	Yes	10, 14	
ISL83088E	Half	10	No	No	256	Yes	530	Yes	8	

TABLE 1. SUMMARY OF FEATURES

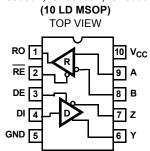
Pinouts



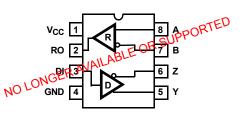




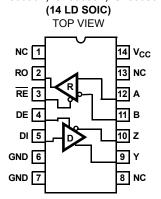
ISL83080E, ISL83083E, ISL83086E (10 L D MSOP)



ISL83084E (8 LD SOIC) TOP VIEW



ISL83080E, ISL83083E, ISL83086E (14 LD SOIC)



Ordering Information

PART NUMBER (Note 1)	PART MARKING	TEMP. RANGE (°C)	PACKAGE (RoHS Compliant)	PKG. DWG. #
ISL83080EIBZ (Note 2)	83080EIBZ	-40 to +85	14 Ld SOIC	M14.15
ISL83080EIUZ (Note 2)	3080Z	-40 to +85	10 Ld MSOP	M10.118
ISL83082EIBZ (Note 2)	83082 EIBZ	-40 to +85	8 Ld SOIC	M8.15
ISL83082EIUZ (Note 2)	3082Z	-40 to +85	8 Ld MSOP	M8.118
ISL83083EIBZ (Note 2)	83083EIBZ	-40 to +85	14 Ld SOIC	M14.15
ISL83083EIUZ (Note 2)	3083Z	-40 to +85	10 Ld MSOP	M10.118
ISL83084EIBZ (Note 2) (No longer available or supported, Recommended Replacements ISL83080EIBZ or ISL83088EIBZ)	83084 EIBZ	-40 to +85	8 Ld SOIC	M8.15
ISL83085EIBZ (Note 2)	83085 EIBZ	-40 to +85	8 Ld SOIC	M8.15
ISL83085EIUZ (Note 2)	3085Z	-40 to +85	8 Ld MSOP	M8.118
ISL83086EIBZ (Note 2)	83086EIBZ	-40 to +85	14 Ld SOIC	M14.15
ISL83086EIUZ (Note 2)	3086Z	-40 to +85	10 Ld MSOP	M10.118
ISL83088EIBZ (Note 2)	83088 EIBZ	-40 to +85	8 Ld SOIC	M8.15
ISL83088EIUZ (Note 2)	3088Z	-40 to +85	8 Ld MSOP	M8.118

NOTES:

1. Add "-T" suffix for tape and reel. Please refer to TB347 for details on reel specifications.

 These Intersil Pb-free plastic packaged products employ special Pb-free material sets, molding compounds/die attach materials, and 100% matte tin plate plus anneal (e3 termination finish, which is RoHS compliant and compatible with both SnPb and Pb-free soldering operations). Intersil Pb-free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J STD-020.

Truth Tables

TRANSMITTING							
	INPUTS	OUTPUTS					
RE	DE	DI	Z	Y			
Х	1	1	0	1			
Х	1	0	1	0			
0	0	Х	High-Z	High-Z			
1	0	Х	High-Z *	High-Z*			

NOTE: *Shutdown Mode (See Notes 10 and 13).

	RECEIVING								
	INPUTS								
RE	DE Half Duplex	DE Full Duplex	A-B	RO					
0	0	Х	≥ -0.05V	1					
0	0	Х	\leq -0.2V	0					
0	0	Х	Inputs Open/Shorted	1					
1	0	0	Х	High-Z*					
1	1	1	Х	High-Z					

NOTE: *Shutdown Mode (See Notes 10 and 13).

Pin Descriptions

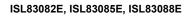
PIN	FUNCTION
RO	Receiver output: If A - B \geq -50mV, RO is high; If A - B \leq -200mV, RO is low; RO = High if A and B are unconnected (floating) or shorted.
RE	Receiver output enable. RO is enabled when \overline{RE} is low; RO is high impedance when \overline{RE} is high.
DE	Driver output enable. The driver outputs, Y and Z, are enabled by bringing DE high. They are high impedance when DE is low.

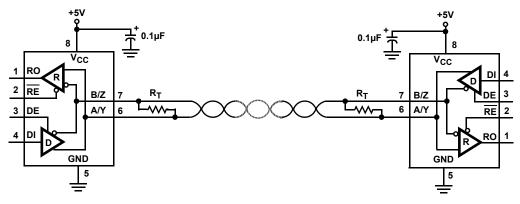


Pin Descriptions (Continued)

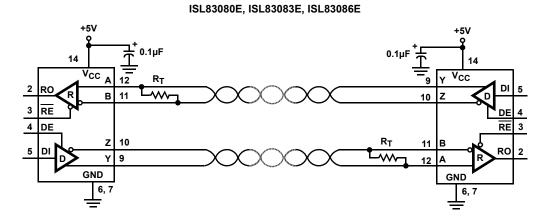
PIN	FUNCTION
DI	Driver input. A low on DI forces output Y low and output Z high. Similarly, a high on DI forces output Y high and output Z low.
GND	Ground connection.
A/Y	±15kV HBM ESD Protected RS-485/RS-422 level, noninverting receiver input and noninverting driver output. Pin is an input if DE = 0; pin is an output if DE = 1.
B/Z	±15kV HBM ESD Protected RS-485/RS-422 level, Inverting receiver input and inverting driver output. Pin is an input if DE = 0; pin is an output if DE = 1.
A	±15kV HBM ESD Protected RS-485/RS-422 level, noninverting receiver input.
В	±15kV HBM ESD Protected RS-485/RS-422 level, inverting receiver input.
Y	±15kV HBM ESD Protected RS-485/RS-422 level, noninverting driver output.
Z	±15kV HBM ESD Protected RS-485/RS-422 level, inverting driver output.
V _{CC}	System power supply input (4.5V to 5.5V).
NC	No Connection.

Typical Operating Circuit

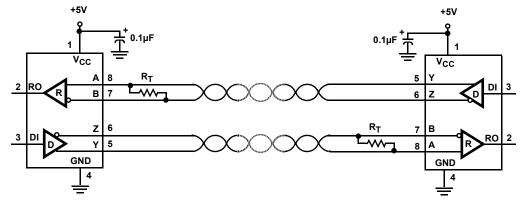




Typical Operating Circuit (Continued)



ISL83084E





Absolute Maximum Ratings

V _{CC} to Ground	Thermal Resistance (Typical
Input Voltages DI, DE, RE	8 Ld SOIC Package
Input/Output Voltages	8 Ld MSOP Package 10 Ld MSOP Package
A, B, Y, Z9V to +13V	14 Ld SOIC Package
A, B, Y, Z (Transient Pulse Through 100Ω , Note 14) $\pm 75V$ RO	Maximum Junction Temperat
Short Circuit Duration	Maximum Storage Temperate Pb-free reflow profile
Y, Z Continuous ESD Rating See Specification Table	http://www.intersil.com/pbf

Thermal Information

8 Ld MSOP Package 1 10 Ld MSOP Package 1	(°C/W)
8 Ld MSOP Package 1 10 Ld MSOP Package 1 14 Ld SOIC Package 1 Maximum Junction Temperature (Plastic Package) 4 Maximum Storage Temperature Range	105
10 Ld MSOP Package 1 14 Ld SOIC Package 1 Maximum Junction Temperature (Plastic Package) 4 Maximum Storage Temperature Range	140
14 Ld SOIC Package	190
Maximum Storage Temperature Range	128
	+150°C
Pb-free reflow profilesee link	+150°C
	< below
http://www.intersil.com/pbfree/Pb-FreeReflow.asp	

Operating Conditions

Temperature Range-40°C to +85°C

CAUTION: Do not operate at or near the maximum ratings listed for extended periods of time. Exposure to such conditions may adversely impact product reliability and result in failures not covered by warranty.

NOTE:

3. θ_{JA} is measured with the component mounted on a high effective thermal conductivity test board in free air. See Tech Brief TB379 for details.

PARAMETER	SYMBOL	TEST CONDIT	ONS	TEMP (°C)	MIN (Note 4)	ТҮР	MAX (Note 4)	UNITS
DC CHARACTERISTICS	I				I			<u>.</u>
Driver Differential V _{OUT} (no load)	V _{OD1}			Full	-	-	V _{CC}	V
Driver Differential V_{OUT} (with load)	V _{OD2}	R _L = 100Ω (RS-422) (Figure	e 1A)	Full	2	2.9	-	V
		$R_L = 54\Omega$ (RS-485) (Figure	1A)	Full	1.5	2.4	V _{CC}	V
		R_L = 60 Ω , -7V \leq V _{CM} \leq 12V (Figure 1B)		Full	1.5	2.6	-	V
Change in Magnitude of Driver Differential V _{OUT} for Complementary Output States	ΔV _{OD}	R _L = 54Ω or 100Ω (Figure 1A)		Full	-	0.01	0.2	V
Driver Common-Mode V _{OUT}	V _{OC}	R_L = 54 Ω or 100 Ω (Figure 1A)		Full	-	2.85	3	V
Change in Magnitude of Driver Common-Mode V _{OUT} for Complementary Output States	ΔV _{OC}	$R_L = 54\Omega$ or 100Ω (Figure 1A)		Full	-	0.01	0.1	V
Logic Input High Voltage	V _{IH}	DE, DI, RE		Full	2	-	-	V
Logic Input Low Voltage	V _{IL}	DE, DI, RE		Full	-	-	0.8	V
DI Input Hysteresis Voltage	V _{HYS}			25	-	100	-	mV
Logic Input Current	I _{IN1}	DE, DI, RE		Full	-2	-	2	μA
Input Current (A, B)	I _{IN2}	DE = 0V, V _{CC} = 0V or 5.5V	V _{IN} = 12V	Full	-	70	125	μA
			V _{IN} = -7V	Full	-75	55	-	μA
Output Leakage Current (Y, Z) (Full	I _{IN3}	$\overline{RE} = 0V, DE = 0V, V_{CC} = 0V$	V _{IN} = 12V	Full	-	7	125	μA
Duplex Versions Only)		or 5.5V (Note 13)	V _{IN} = -7V		11	-	μA	
Output Leakage Current (Y, Z)	I _{IN3}	$\overline{\text{RE}} = V_{CC}, \text{ DE} = 0V, V$	V _{IN} = 12V	Full	-	0	20	μA
in Shutdown Mode (Full Duplex)		V _{CC} = 0V or 5.5V (Note 13)	V _{IN} = -7V	Full	-20	9	-	μA
Driver Short-Circuit Current, $V_O =$ High or Low	I _{OSD1}	DE = V_{CC} , -7V \leq V _Y or V _Z \leq	12V (Note 7)	Full	-	-	±250	mA

Electrical Specifications Test Conditions: V_{CC} = 4.5V to 5.5V; Unless Otherwise Specified. Typicals are at V_{CC} = 5V, T_A = +25°C



Electrical Specifications Test Conditions: V_{CC} = 4.5V to 5.5V; Unless Otherwise Specified. Typicals are at V_{CC} = 5V, T_A = +25°C (Note 5). (Continued)

	Note 5). (Continued)			MAINI		MAX	1
PARAMETER	SYMBOL	TEST CONDITIONS	TEMP (°C)	MIN (Note 4)	ТҮР	(Note 4)	UNITS
Receiver Differential Threshold Voltage	V _{TH}	$-7V \le V_{CM} \le 12V$	Full	-200	-90	-50	mV
Receiver Input Hysteresis	ΔV_{TH}	V _{CM} = 0V	25	-	20	-	mV
Receiver Output High Voltage	V _{OH}	I _O = -4mA, V _{ID} = -50mV	Full	V _{CC} - 1	4.6	-	V
Receiver Output Low Voltage	V _{OL}	I _O = -4mA, V _{ID} = -200mV	Full	-	0.2	0.4	V
Three-State (high impedance) Receiver Output Current	I _{OZR}	$0.4V \le V_O \le 2.4V$ (Note 13)	Full	-1	0.03	1	μA
Receiver Input Resistance	R _{IN}	$-7V \le V_{CM} \le 12V$	Full	96	160	-	kΩ
Receiver Short-Circuit Current	I _{OSR}	$0V \le V_O \le V_{CC}$	Full	±7	-	±85	mA
SUPPLY CURRENT	L		I		1		
No-Load Supply Current (Note 6)	ICC	Half Duplex Versions, DE = V_{CC} , \overline{RE} = X, DI = 0V or V_{CC}	Full	-	560	700	μA
		All Versions, DE = 0V, \overline{RE} = 0V, or Full Duplex Versions, DE = V _{CC} , \overline{RE} = X. DI = 0V or V _{CC}	Full	-	530	650	μA
Shutdown Supply Current	I _{SHDN}	$DE = 0V, \overline{RE} = V_{CC}, DI = 0V \text{ or } V_{CC} \text{ (Note 13)}$	Full	-	0.07	2	μA
ESD PERFORMANCE	L						
RS-485 Pins (A, Y, B, Z)		Human Body Model (HBM), Pin to GND	25	-	±15	-	kV
All Other Pins		HBM, per MIL-STD-883 Method 3015	25	-	±7	-	kV
		Machine Model	25	-	> ±250	-	V
DRIVER SWITCHING CHARACTE	RISTICS (11	5kbps Versions; ISL83080E, ISL83082E)					
Driver Differential Output Delay	t _{PLH} , t _{PHL}	R_{DIFF} = 54 Ω , C_{L} = 100pF (Figure 2)	Full	500	780	1300	ns
Driver Differential Output Skew	t _{SKEW}	R_{DIFF} = 54 Ω , C_{L} = 100pF (Figure 2)	Full	-	40	100	ns
Driver Differential Rise or Fall Time	t _R , t _F	R_{DIFF} = 54 Ω , C_{L} = 100pF (Figure 2)	Full	667	1000	1500	ns
Maximum Data Rate	f _{MAX}	C _D = 820pF (Figure 4) (Note 15)	Full	115	666	-	kbps
Driver Enable to Output High	t _{ZH}	$R_L = 500\Omega$, $C_L = 100$ pF, SW = GND (Figure 3), (Note 8)	Full	-	278	1500	ns
Driver Enable to Output Low	t _{ZL}	$R_L = 500\Omega$, $C_L = 100pF$, SW = V_{CC} (Figure 3) (Note 8)	Full	-	35	1500	ns
Driver Disable from Output Low	t _{LZ}	R_L = 500 Ω , C_L = 15pF, SW = V _{CC} (Figure 3)	Full	-	67	100	ns
Driver Disable from Output High	t _{HZ}	$R_L = 500\Omega$, $C_L = 15pF$, SW = GND (Figure 3)	Full	-	38	100	ns
Time to Shutdown	t _{SHDN}	(Note 10)	Full	60	160	600	ns
Driver Enable from Shutdown to Output High	t _{ZH} (SHDN)	$R_L = 500\Omega, C_L = 100pF, SW = GND (Figure 3)$ (Notes 10, 11)	Full	-	400	2000	ns
Driver Enable from Shutdown to Output Low	^t ZL(SHDN)	$R_L = 500\Omega, C_L = 100pF, SW = V_{CC}$ (Figure 3) (Notes 10, 11)	Full	-	155	2000	ns
DRIVER SWITCHING CHARACTE	RISTICS (50	0kbps Versions; ISL83083E, ISL83084E, ISL8	3085E)				
Driver Differential Output Delay	t _{PLH,} t _{PHL}	R_{DIFF} = 54 Ω , C_{L} = 100pF (Figure 2)	Full	250	360	1000	ns
Driver Differential Output Skew	t _{SKEW}	R_{DIFF} = 54 Ω , C_{L} = 100pF (Figure 2)	Full	-	20	100	ns
Driver Differential Rise or Fall Time	t _R , t _F	R_{DIFF} = 54 Ω , C_{L} = 100pF (Figure 2)	Full	200	475	750	ns
Maximum Data Rate	f _{MAX}	C _D = 820pF (Figure 4) (Note 15)	Full	500	1000	-	kbps



Electrical Specifications Test Conditions: V_{CC} = 4.5V to 5.5V; Unless Otherwise Specified. Typicals are at V_{CC} = 5V, T_A = +25°C (Note 5). (Continued)

PARAMETER	SYMBOL	TEST CONDITIONS	TEMP (°C)	MIN (Note 4)	ТҮР	MAX (Note 4)	UNITS
Driver Enable to Output High	t _{ZH}	R_L = 500Ω, C_L = 100pF, SW = GND (Figure 3), (Notes 8, 13)	Full	-	137	1000	ns
Driver Enable to Output Low	t _{ZL}	R_L = 500 Ω , C_L = 100pF, SW = V _{CC} (Figure 3), (Notes 8, 13)	Full	-	35	1000	ns
Driver Disable from Output Low	tLZ	R_L = 500Ω, C_L = 15pF, SW = V _{CC} (Figure 3), (Note 13)	Full	-	65	100	ns
Driver Disable from Output High	t _{HZ}	$R_L = 500\Omega$, $C_L = 15pF$, SW = GND (Figure 3), (Note 13)	Full	-	38	100	ns
Time to Shutdown	t _{SHDN}	(Note 10)	Full	60	160	600	ns
Driver Enable from Shutdown to Output High	t _{ZH} (SHDN)	$R_L = 500\Omega, C_L = 100$ pF, SW = GND (Figure 3), (Notes 10, 11, 13)	Full	-	260	1500	ns
Driver Enable from Shutdown to Output Low	^t ZL(SHDN)	R_L = 500Ω, C_L = 100pF, SW = V _{CC} (Figure 3), (Notes 10, 11, 13)	Full	-	155	1500	ns
DRIVER SWITCHING CHARACTE	RISTICS (10	Mbps Versions; ISL83086E, ISL83088E)	I				
Driver Differential Output Delay	t _{PLH,} t _{PHL}	R _{DIFF} = 54Ω, C _L = 100pF (Figure 2)	Full	-	20	60	ns
Driver Differential Output Skew	t _{SKEW}	R _{DIFF} = 54Ω, C _L = 100pF (Figure 2)	Full	-	1	10	ns
Driver Differential Rise or Fall Time	t _R , t _F	R_{DIFF} = 54 Ω , C_{L} = 100pF (Figure 2)	Full	-	13	25	ns
Maximum Data Rate	f _{MAX}	C _D = 470pF (Figure 4) (Note 15)	Full	10	15	-	Mbps
Driver Enable to Output High	t _{ZH}	$R_L = 500\Omega$, $C_L = 100$ pF, SW = GND (Figure 3), (Note 8)	Full	-	35	150	ns
Driver Enable to Output Low	t _{ZL}	R_L = 500 Ω , C_L = 100pF, SW = V _{CC} (Figure 3), (Note 8)	Full	-	30	150	ns
Driver Disable from Output Low	t _{LZ}	R_L = 500 Ω , C_L = 15pF, SW = V _{CC} (Figure 3)	Full	-	66	100	ns
Driver Disable from Output High	t _{HZ}	R_L = 500 Ω , C_L = 15pF, SW = GND (Figure 3)	Full	-	38	100	ns
Time to Shutdown	^t SHDN	(Note 10)	Full	60	160	600	ns
Driver Enable from Shutdown to Output High	^t ZH(SHDN)	$R_L = 500\Omega$, $C_L = 100$ pF, SW = GND (Figure 3), (Notes 10, 11)	Full	-	115	250	ns
Driver Enable from Shutdown to Output Low	^t ZL(SHDN)	$R_L = 500\Omega, C_L = 100pF, SW = V_{CC}$ (Figure 3), (Notes 10, 11)	Full	-	84	250	ns
RECEIVER SWITCHING CHARAC	TERISTICS	(115kbps and 500kbps Versions; ISL83080E	THRU IS	L83085E)			
Maximum Data Rate	f _{MAX}	(Figure 5) (Note 15)	Full	0.5	10	-	Mbps
Receiver Input to Output Delay	t _{PLH} , t _{PHL}	(Figure 5)	Full	-	100	150	ns
Receiver Skew t _{PLH} - t _{PHL}	^t SKD	(Figure 5)	Full	-	7	10	ns
Receiver Enable to Output Low	t _{ZL}	R_L = 1kΩ, C_L = 15pF, SW = V _{CC} (Figure 6), (Notes 9, 13)	Full	-	10	50	ns
Receiver Enable to Output High	t _{ZH}	R_L = 1kΩ, C_L = 15pF, SW = GND (Figure 6), (Notes 9, 13)	Full	-	10	50	ns
Receiver Disable from Output Low	t _{LZ}	R_L = 1kΩ, C_L = 15pF, SW = V _{CC} (Figure 6), (Note 13)	Full	-	10	50	ns
Receiver Disable from Output High	t _{HZ}	R_L = 1kΩ, C_L = 15pF, SW = GND (Figure 6), (Note 13)	Full	-	10	50	ns
Time to Shutdown	t _{SHDN}	(Notes 10, 13)	Full	60	160	600	ns



Electrical Specifications Test Conditions: V_{CC} = 4.5V to 5.5V; Unless Otherwise Specified. Typicals are at V_{CC} = 5V, T_A = +25°C (Note 5). (Continued)

PARAMETER	SYMBOL	TEST CONDITIONS	TEMP (°C)	MIN (Note 4)	ТҮР	MAX (Note 4)	UNITS
Receiver Enable from Shutdown to Output High	t _{ZH} (SHDN)	R_L = 1kΩ, C_L = 15pF, SW = GND (Figure 6), (Notes 10, 12, 13)	Full	-	150	2000	ns
Receiver Enable from Shutdown to Output Low	^t ZL(SHDN)	R_L = 1kΩ, C_L = 15pF, SW = V _{CC} (Figure 6), (Notes 10, 12, 13)	Full	-	150	2000	ns
RECEIVER SWITCHING CHARAC	TERISTICS	(10Mbps Versions; ISL83086E, ISL83088E)	1			1	
Maximum Data Rate	f _{MAX}	(Figure 5) (Note 15)	Full	10	15	-	Mbps
Receiver Input to Output Delay	t _{PLH} , t _{PHL}	(Figure 5)	Full	-	70	125	ns
Receiver Skew t _{PLH} - t _{PHL}	t _{SKD}	(Figure 5)	Full	-	0	10	ns
Receiver Enable to Output Low	t _{ZL}	R_L = 1kΩ, C_L = 15pF, SW = V _{CC} (Figure 6) (Note 9)	Full	-	10	30	ns
Receiver Enable to Output High	t _{ZH}	R_L = 1kΩ, C_L = 15pF, SW = GND (Figure 6) (Note 9)	Full	-	10	30	ns
Receiver Disable from Output Low	t _{LZ}	R_L = 1k Ω , C_L = 15pF, SW = V _{CC} (Figure 6)	Full	-	10	30	ns
Receiver Disable from Output High	t _{HZ}	$R_L = 1k\Omega$, $C_L = 15pF$, SW = GND (Figure 6)	Full	-	10	30	ns
Time to Shutdown	t _{SHDN}	(Note 10)	Full	60	160	600	ns
Receiver Enable from Shutdown to Output High	^t ZH(SHDN)	R_L = 1kΩ, C_L = 15pF, SW = GND (Figure 6) (Notes 10, 12)	Full	-	150	2000	ns
Receiver Enable from Shutdown to Output Low	t _{ZL(SHDN)}	R_L = 1kΩ, C_L = 15pF, SW = V _{CC} (Figure 6) (Notes 10, 12)	Full	-	150	2000	ns

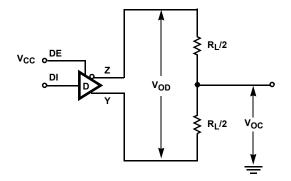
NOTES:

4. Parameters with MIN and/or MAX limits are 100% tested at +25°C, unless otherwise specified. Temperature limits established by characterization and are not production tested.

- 5. All currents into device pins are positive; all currents out of device pins are negative. All voltages are referenced to device ground unless otherwise specified.
- 6. Supply current specification is valid for loaded drivers when DE = 0V.
- 7. Applies to peak current. See "Typical Performance Curves" beginning on page 13 for more information.
- 8. Keep \overline{RE} = 0 to prevent the device from entering SHDN.
- 9. The RE signal high time must be short enough (typically <100ns) to prevent the device from entering SHDN.
- 10. Transceivers are put into shutdown by bringing RE high and DE low. If the inputs are in this state for less than 60ns, the parts are guaranteed not to enter shutdown. If the inputs are in this state for at least 600ns, the parts are guaranteed to have entered shutdown. See "Low Power Shutdown Mode" on page 13.
- 11. Keep \overline{RE} = VCC, and set the DE signal low time >600ns to ensure that the device enters SHDN.
- 12. Set the $\overline{\text{RE}}$ signal high time >600ns to ensure that the device enters SHDN.
- 13. Does not apply to the ISL83084E.
- 14. Tested according to TIA/EIA-485-A, section 4.2.6 (±75V for 15µs at a 1% duty cycle).
- 15. Limits established by characterization and are not production tested.



Test Circuits and Waveforms



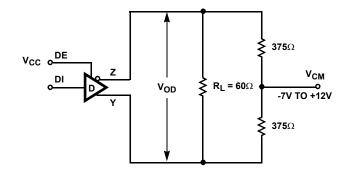


FIGURE 1B. VOD WITH COMMON MODE LOAD

1.5V

90%

10%

tp

3V

0V

VOH

VOL

+VOD

-VOD

1.5V

tPHL

90%

10%

te

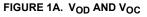


FIGURE 1. DC DRIVER TEST CIRCUITS

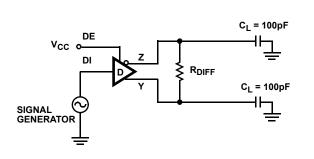


FIGURE 2A. TEST CIRCUIT

SKEW = |t_{PLH} - t_{PHL}|

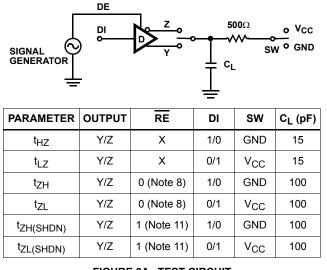
FIGURE 2B. MEASUREMENT POINTS FIGURE 2. DRIVER PROPAGATION DELAY AND DIFFERENTIAL TRANSITION TIMES

DI

OUT (Z)

OUT (Y)

DIFF OUT (Y - Z)



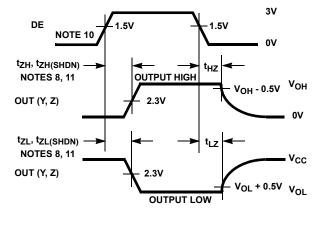


FIGURE 3A. TEST CIRCUIT

FIGURE 3B. MEASUREMENT POINTS

FIGURE 3. DRIVER ENABLE AND DISABLE TIMES (DOES NOT APPLY TO THE ISL83084E)



Test Circuits and Waveforms (Continued)

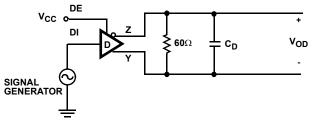


FIGURE 4A. TEST CIRCUIT

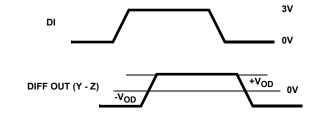


FIGURE 4B. MEASUREMENT POINTS

+1.5V

-1.5V

.5V

Vcc

0V

٥v

t_{PHL}



Α

RO

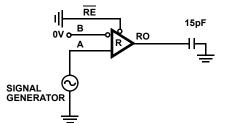


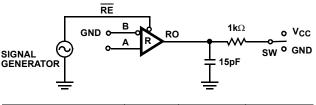
FIGURE 5A. TEST CIRCUIT

FIGURE 5B. MEASUREMENT POINTS

<u>5\</u>

٥v

FIGURE 5. RECEIVER PROPAGATION DELAY AND DATA RATE



PARAMETER	DE	Α	SW
t _{HZ}	0	+1.5V	GND
t _{LZ}	0	-1.5V	V _{CC}
t _{ZH} (Note 9)	0	+1.5V	GND
t _{ZL} (Note 9)	0	-1.5V	V _{CC}
t _{ZH(SHDN)} (Note 12)	0	+1.5V	GND
t _{ZL(SHDN)} (Note 12)	0	-1.5V	V _{CC}

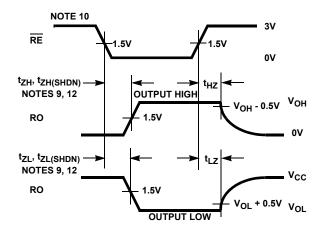


FIGURE 6A. TEST CIRCUIT

FIGURE 6B. MEASUREMENT POINTS

FIGURE 6. RECEIVER ENABLE AND DISABLE TIMES (DOES NOT APPLY TO THE ISL83084E)

Application Information

RS-485 and RS-422 are differential (balanced) data transmission standards for use in long haul or noisy environments. RS-422 is a subset of RS-485, so RS-485 transceivers are also RS-422 compliant. RS-422 is a point-to-multipoint (multidrop) standard, which allows only one driver and up to 10 (assuming one unit load devices) receivers on each bus. RS-485 is a true multipoint standard, which allows up to 32 one unit load devices (any combination of drivers and receivers) on each bus. To allow for multipoint operation, the RS-485 specification requires that drivers must handle bus contention without sustaining any damage.



Another important advantage of RS-485 is the extended common mode range (CMR), which specifies that the driver outputs and receiver inputs withstand signals that range from +12V to -7V. RS-422 and RS-485 are intended for runs as long as 4000', so the wide CMR is necessary to handle ground potential differences, as well as voltages induced in the cable by external fields.

Receiver Features

These devices utilize a differential input receiver for maximum noise immunity and common mode rejection. Input sensitivity is ± 200 mV, as required by the RS-422 and RS-485 specifications.

Receiver input resistance of 96k Ω surpasses the RS-422 specification of 4k Ω , and is eight times the RS-485 "Unit Load (UL)" requirement of 12k Ω minimum. Thus, these products are known as "one-eighth UL" transceivers, and there can be up to 256 of these devices on a network while still complying with the RS-485 loading specification.

Receiver inputs function with common mode voltages as great as ±7V outside the power supplies (i.e., +12V and -7V), making them ideal for long networks where induced voltages are a realistic concern.

All the receivers include a "full fail-safe" function that guarantees a high level receiver output if the receiver inputs are unconnected (floating) or shorted.

Receivers easily meet the data rates supported by the corresponding driver, and all receiver outputs are three-statable via the active low $\overline{\text{RE}}$ input (except for the ISL83084E).

Driver Features

The RS-485/RS-422 driver is a differential output device that delivers at least 1.5V across a 54 Ω load (RS-485), and at least 2V across a 100 Ω load (RS-422). The drivers feature low propagation delay skew to maximize bit width, and to minimize EMI.

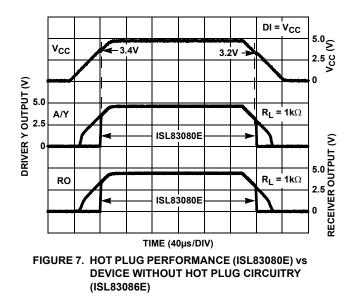
All drivers are three-statable via the active high DE input (except for the ISL83084E).

The 115kbps and 500kbps driver outputs are slew rate limited to minimize EMI, and to minimize reflections in unterminated or improperly terminated networks. Outputs of the ISL83086E, ISL83088E drivers are not limited, so faster output transition times allow data rates of at least 10Mbps.

Hot Plug Function

When a piece of equipment powers up, there is a period of time where the processor or ASIC driving the RS-485 control lines (DE, \overline{RE}) is unable to ensure that the RS-485 Tx and Rx outputs are kept disabled. If the equipment is connected to the bus, a driver activating prematurely during power-up may crash the bus. To avoid this scenario, the ISL83080, ISL83082, ISL83083, ISL83085 versions incorporate a "Hot Plug" function. Circuitry monitoring V_{CC} ensures that, during

power-up and power-down, the Tx and Rx outputs remain disabled, regardless of the state of DE and $\overline{\text{RE}}$, if V_{CC} is less than ~3.4V. This gives the processor/ASIC a chance to stabilize and drive the RS-485 control lines to the proper states.



ESD Protection

All pins on these devices include class 3 Human Body Model (HBM) ESD protection structures, but the RS-485 pins (driver outputs and receiver inputs) incorporate advanced structures allowing them to survive ESD events in excess of ±15kV HBM. The RS-485 pins are particularly vulnerable to ESD damage because they typically connect to an exposed port on the exterior of the finished product. Simply touching the port pins, or connecting a cable, can cause an ESD event that might destroy unprotected ICs. These new ESD structures protect the device whether or not it is powered up, protect without allowing any latchup mechanism to activate, and without degrading the RS-485 common mode range of -7V to +12V. This built-in ESD protection eliminates the need for board level protection structures (e.g., transient suppression diodes), and the associated, undesirable capacitive load they present.

Data Rate, Cables, and Terminations

RS-485/RS-422 are intended for network lengths up to 4000', but the maximum system data rate decreases as the transmission length increases. Devices operating at 10Mbps are limited to lengths less than 100', while the 115kbps versions can operate at full data rates with lengths of several 1000'.

Twisted pair is the cable of choice for RS-485/RS-422 networks. Twisted pair cables tend to pick up noise and other electromagnetically induced voltages as common mode signals, which are effectively rejected by the differential receivers in these ICs.

Proper termination is imperative (when using the 10Mbps devices) to minimize reflections. Short networks using the



115kbps versions need not be terminated, but, terminations are recommended unless power dissipation is an overriding concern.

In point-to-point, or point-to-multipoint (single driver on bus) networks, the main cable should be terminated in its characteristic impedance (typically 120Ω) at the end farthest from the driver. In multi-receiver applications, stubs connecting receivers to the main cable should be kept as short as possible. Multipoint (multi-driver) systems require that the main cable be terminated in its characteristic impedance at both ends. Stubs connecting a transceiver to the main cable should be kept as short as possible.

Built-In Driver Overload Protection

As stated previously, the RS-485 specification requires that drivers survive worst case bus contentions undamaged. These devices meet this requirement via driver output short circuit current limits, and on-chip thermal shutdown circuitry.

The driver output stages incorporate short circuit current limiting circuitry which ensures that the output current never exceeds the RS-485 specification, even at the common mode voltage range extremes. Additionally, these devices utilize a foldback circuit which reduces the short circuit current, and thus the power dissipation, whenever the contending voltage exceeds either supply. In the event of a major short circuit condition, devices also include a thermal shutdown feature that disables the drivers whenever the die temperature becomes excessive. This eliminates the power dissipation, allowing the die to cool. The drivers automatically re-enable after the die temperature drops about +15°C. If the contention persists, the thermal shutdown/re-enable cycle repeats until the fault is cleared. Receivers stay operational during thermal shutdown.

Low Power Shutdown Mode

These CMOS transceivers all use a fraction of the power required by their bipolar counterparts, but they also include a shutdown feature (except for the ISL83084E) that reduces the already low quiescent I_{CC} to a 70nA trickle. These devices enter shutdown whenever the receiver and driver are *simultaneously* disabled ($\overline{RE} = V_{CC}$ and DE = GND) for a period of at least 600ns. Disabling both the driver and the receiver for less than 60ns guarantees that the transceiver will not enter shutdown.

Note that receiver and driver enable times increase when the transceiver enables from shutdown. Refer to Notes 8 thru 12, at the end of the "Electrical Specification Table" on page 9, for more information.

Typical Performance Curves V_{CC} = 5V, T_A = +25°C; Unless Otherwise Specified

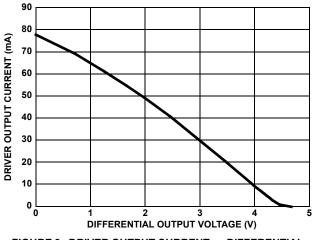
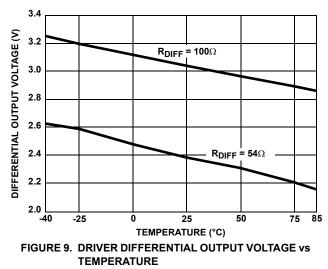
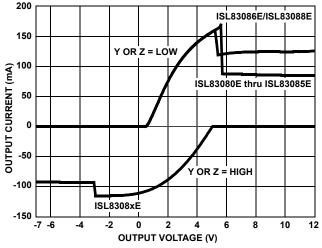
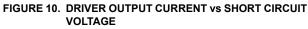


FIGURE 8. DRIVER OUTPUT CURRENT vs DIFFERENTIAL OUTPUT VOLTAGE





Typical Performance Curves V_{CC} = 5V, T_A = +25°C; Unless Otherwise Specified (Continued)



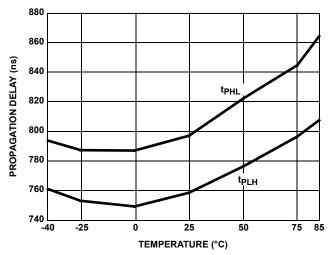
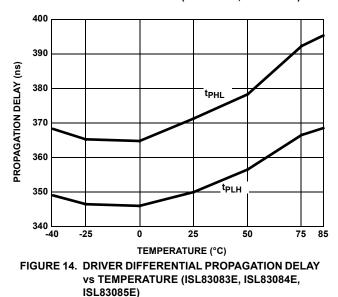
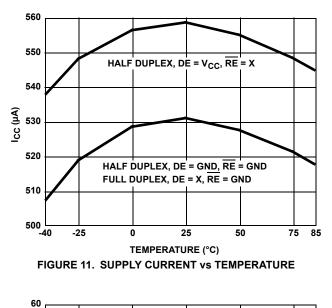


FIGURE 12. DRIVER DIFFERENTIAL PROPAGATION DELAY vs TEMPERATURE (ISL83080E, ISL83082E)





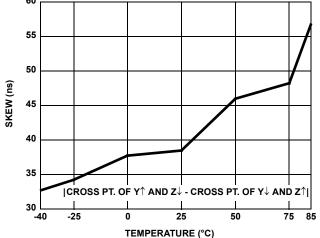
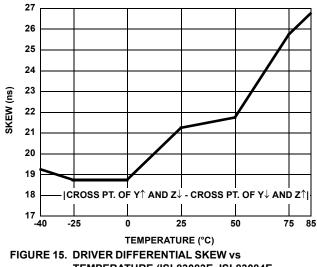


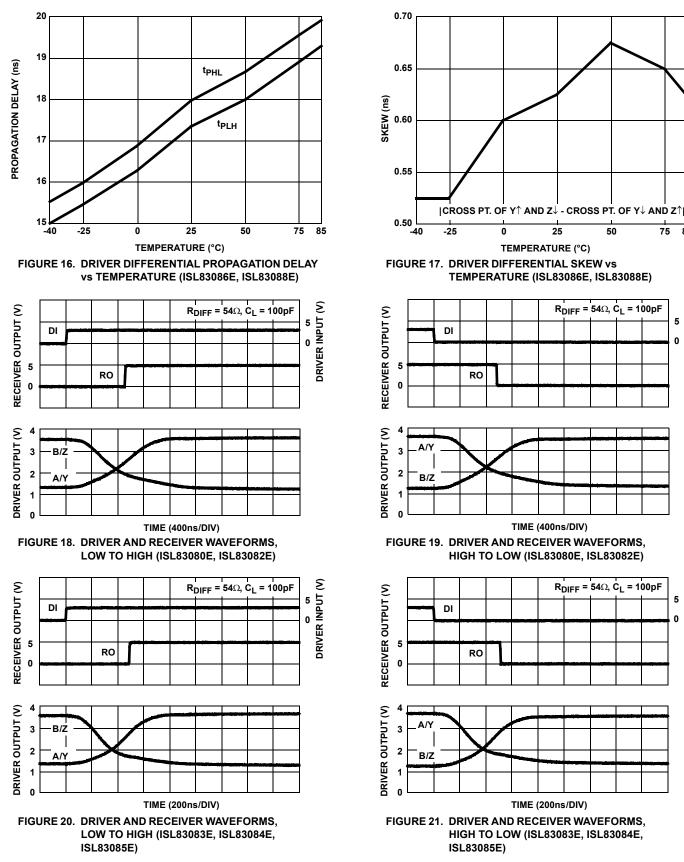
FIGURE 13. DRIVER DIFFERENTIAL SKEW vs TEMPERATURE (ISL83080E, ISL83082E)



TEMPERATURE (ISL83083E, ISL83084E, ISL83085E)

FN6085 Rev 10.00 February 15, 2016

Typical Performance Curves $V_{CC} = 5V$, $T_A = +25^{\circ}C$; Unless Otherwise Specified (Continued)



RENESAS

75 85

DRIVER INPUT (V)

DRIVER INPUT (V)

5

0

5

0

Typical Performance Curves $V_{CC} = 5V$, $T_A = +25^{\circ}C$; Unless Otherwise Specified (Continued)

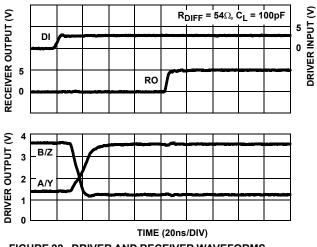


FIGURE 22. DRIVER AND RECEIVER WAVEFORMS, LOW TO HIGH (ISL83086E, ISL83088E)

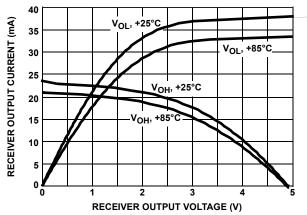
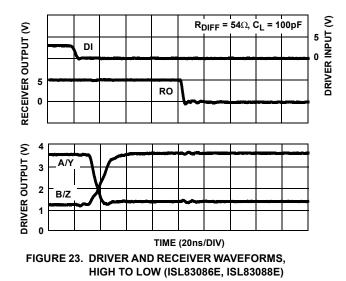


FIGURE 24. RECEIVER OUTPUT CURRENT vs RECEIVER OUTPUT VOLTAGE



Die Characteristics

SUBSTRATE POTENTIAL (POWERED UP):

GND

TRANSISTOR COUNT:

525

PROCESS:

Si Gate BiCMOS

Revision History

The revision history provided is for informational purposes only and is believed to be accurate, but not warranted. Please go to the web to make sure that you have the latest revision.

DATE	REVISION	CHANGE
February 15, 2016	FN6085.10	Added Rev History and About Intersil verbiage. Updated "Ordering Information" on page 3. Updated POD M8.118 to current version with following changes: Updated to new Intersil format by adding land pattern and moving dimensions from table onto drawing Corrected lead width dimension in side view 1 from "0.25 - 0.036" to "0.25 - 0.36" Updated POD M10.118 to current version with following change: Updated POD M10.118 to current version with following change: Updated POD M14.15 to current version with following change: Added land pattern and moved dimensions from table onto drawing. Updated POD M8.15 to current version with following changes: Updated POD M8.15 to current version with following changes: Updated ronew POD format by removing table and moving dimensions onto drawing and adding land pattern. Changed in Typical Recommended Land Pattern the following: 2.41(0.095) to 2.20(0.087) 0.76 (0.030) to 0.60(0.023) 0.200 to 5.20(0.205) Changed Note 1 "1982" to "1994"

About Intersil

Intersil Corporation is a leading provider of innovative power management and precision analog solutions. The company's products address some of the largest markets within the industrial and infrastructure, mobile computing and high-end consumer markets.

For the most updated datasheet, application notes, related documentation and related parts, please see the respective product information page found at <u>www.intersil.com</u>.

You may report errors or suggestions for improving this datasheet by visiting <u>www.intersil.com/ask</u>.

Reliability reports are also available from our website at www.intersil.com/support.

© Copyright Intersil Americas LLC 2004-2016. All Rights Reserved. All trademarks and registered trademarks are the property of their respective owners.

For additional products, see www.intersil.com/en/products.html

Intersil products are manufactured, assembled and tested utilizing ISO9001 quality systems as noted in the quality certifications found at www.intersil.com/en/support/qualandreliability.html

Intersil products are sold by description only. Intersil may modify the circuit design and/or specifications of products at any time without notice, provided that such modification does not, in Intersil's sole judgment, affect the form, fit or function of the product. Accordingly, the reader is cautioned to verify that datasheets are current before placing orders. Information furnished by Intersil is believed to be accurate and reliable. However, no responsibility is assumed by Intersil or its subsidiaries for its use; nor for any infringements of patents or other rights of third parties which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of Intersil or its subsidiaries.

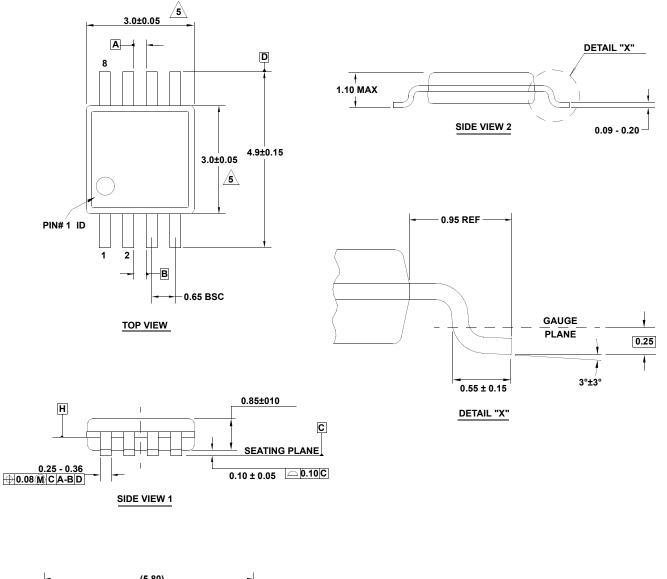
For information regarding Intersil Corporation and its products, see www.intersil.com

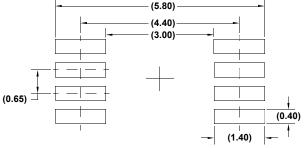
FN6085 Rev 10.00 February 15, 2016



M8.118

8 LEAD MINI SMALL OUTLINE PLASTIC PACKAGE Rev 4, 7/11





TYPICAL RECOMMENDED LAND PATTERN

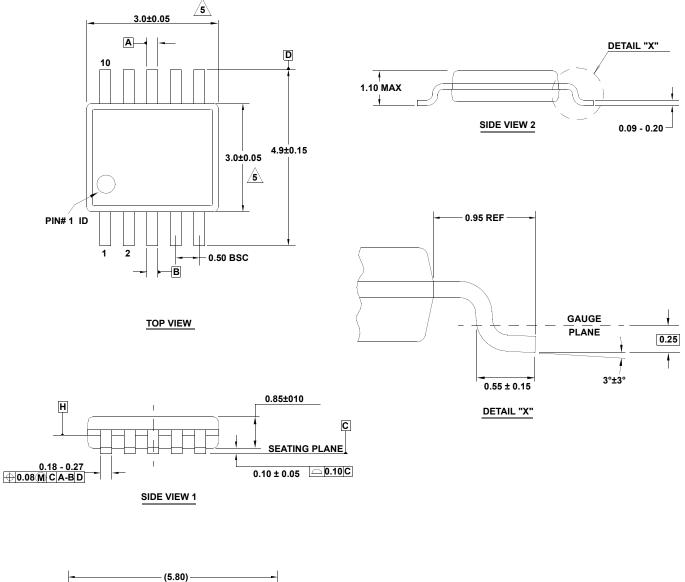
NOTES:

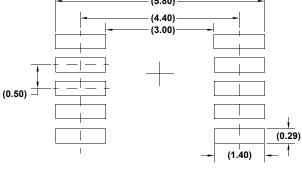
- 1. Dimensions are in millimeters.
- 2. Dimensioning and tolerancing conform to JEDEC MO-187-AA and AMSEY14.5m-1994.
- 3. Plastic or metal protrusions of 0.15mm max per side are not included.
- 4. Plastic interlead protrusions of 0.15mm max per side are not included.
- 5. Dimensions are measured at Datum Plane "H".
- 6. Dimensions in () are for reference only.



M10.118

10 LEAD MINI SMALL OUTLINE PLASTIC PACKAGE Rev 1, 4/12





TYPICAL RECOMMENDED LAND PATTERN

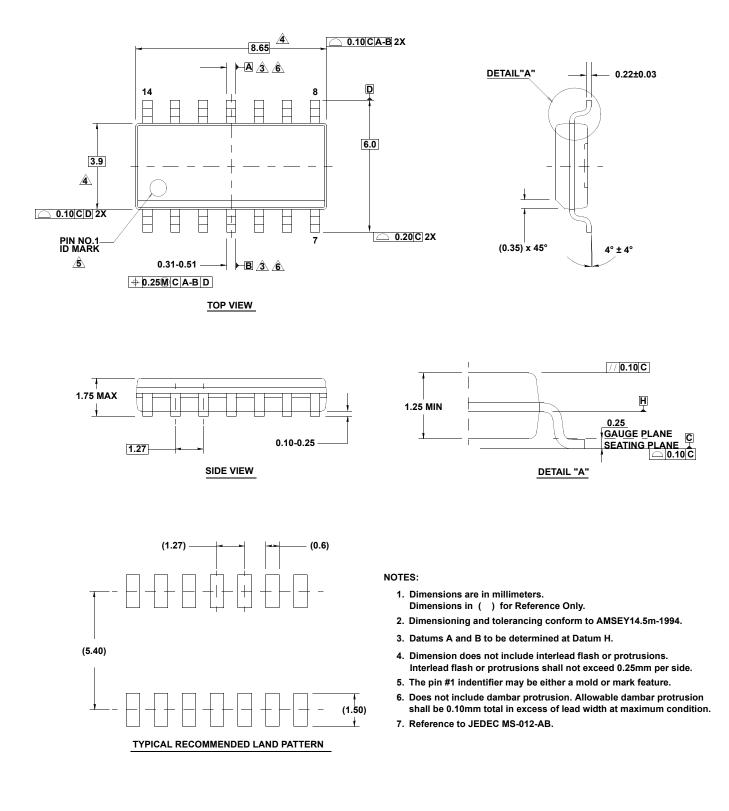
NOTES:

- 1. Dimensions are in millimeters.
- 2. Dimensioning and tolerancing conform to JEDEC MO-187-BA and AMSEY14.5m-1994.
- 3. Plastic or metal protrusions of 0.15mm max per side are not included.
- 4. Plastic interlead protrusions of 0.15mm max per side are not included.
- 5. Dimensions are measured at Datum Plane "H".
- 6. Dimensions in () are for reference only.



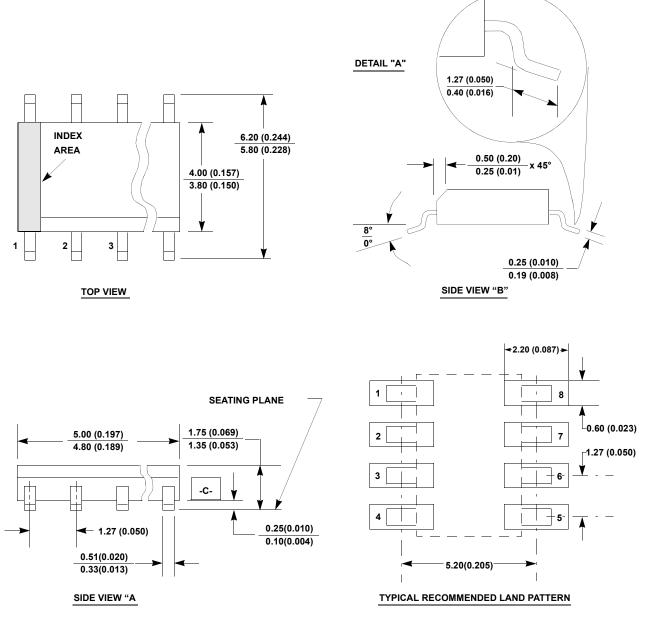
M14.15

14 LEAD NARROW BODY SMALL OUTLINE PLASTIC PACKAGE Rev 1, 10/09



M8.15

8 LEAD NARROW BODY SMALL OUTLINE PLASTIC PACKAGE Rev 4, 1/12



NOTES:

- 1. Dimensioning and tolerancing per ANSI Y14.5M-1994.
- Package length does not include mold flash, protrusions or gate burrs. Mold flash, protrusion and gate burrs shall not exceed 0.15mm (0.006 inch) per side.
- 3. Package width does not include interlead flash or protrusions. Interlead flash and protrusions shall not exceed 0.25mm (0.010 inch) per side.
- 4. The chamfer on the body is optional. If it is not present, a visual index feature must be located within the crosshatched area.
- 5. Terminal numbers are shown for reference only.
- The lead width as measured 0.36mm (0.014 inch) or greater above the seating plane, shall not exceed a maximum value of 0.61mm (0.024 inch).
- 7. Controlling dimension: MILLIMETER. Converted inch dimensions are not necessarily exact.
- 8. This outline conforms to JEDEC publication MS-012-AA ISSUE C.

